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CCD Technology for HD Production

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Overview

- History
- HD camera market requirements
- CCD technology
- CCD Benefits
- HD technology in the production marketplace

The road to HD CCD cameras

SD

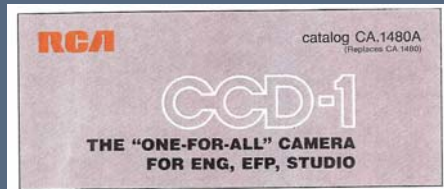
HD

First Solid state X-Y imagers demonstrated

1960s

Bosch FDL-60 CCD-based telecine (line array) 1000 pixels

1979



1982

Sony makes 1" Tube HD camera with NHK

1984

First commercially available HD camera, Sony HDC-300 (1" Saticon Tube)

1992

First CCD HD camera, Sony HDC-500 (1" CCD)

HD Customer Requirements

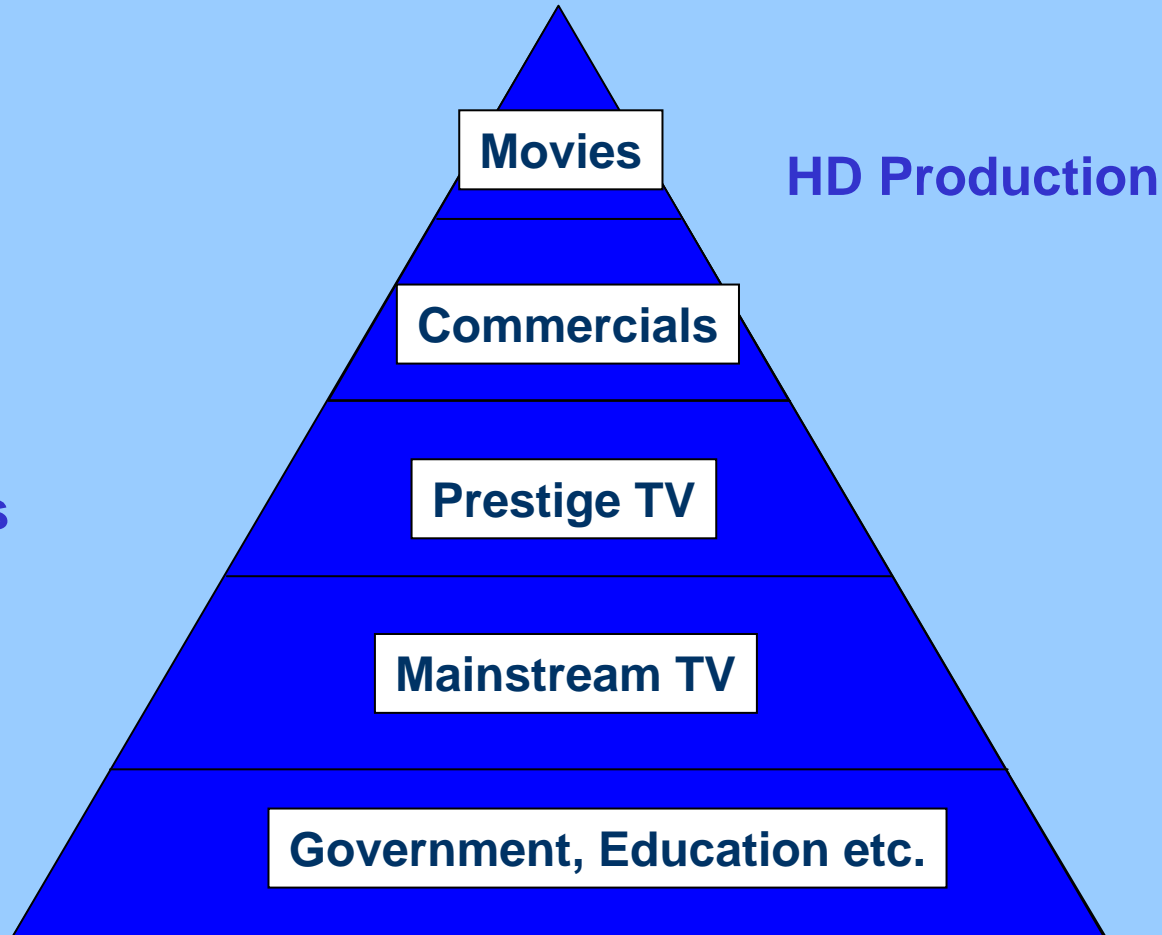
- Low noise
- High sensitivity
- No smear/blooming/highlight overload effects
- High resolution
- Low aliasing
- Lens compatibility (=2/3" Image format)
- Low power consumption
- Support for multiple frame rates
- Low cost

- Ease of manufacture

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HD Applications

Customer requirements will differ by application



Imager technology

- CCD and CMOS
 - both use arrays of discrete pixels
 - both analogue devices
 - Both require A/D conversion process, usually external to the sensor

CMOS

- Individual charge-to-voltage convertors for every pixel
- Random access - pixels can be read out in any sequence, as required
- Voltage readout
- *Possibility* for integrated sensor and image processing

CCD

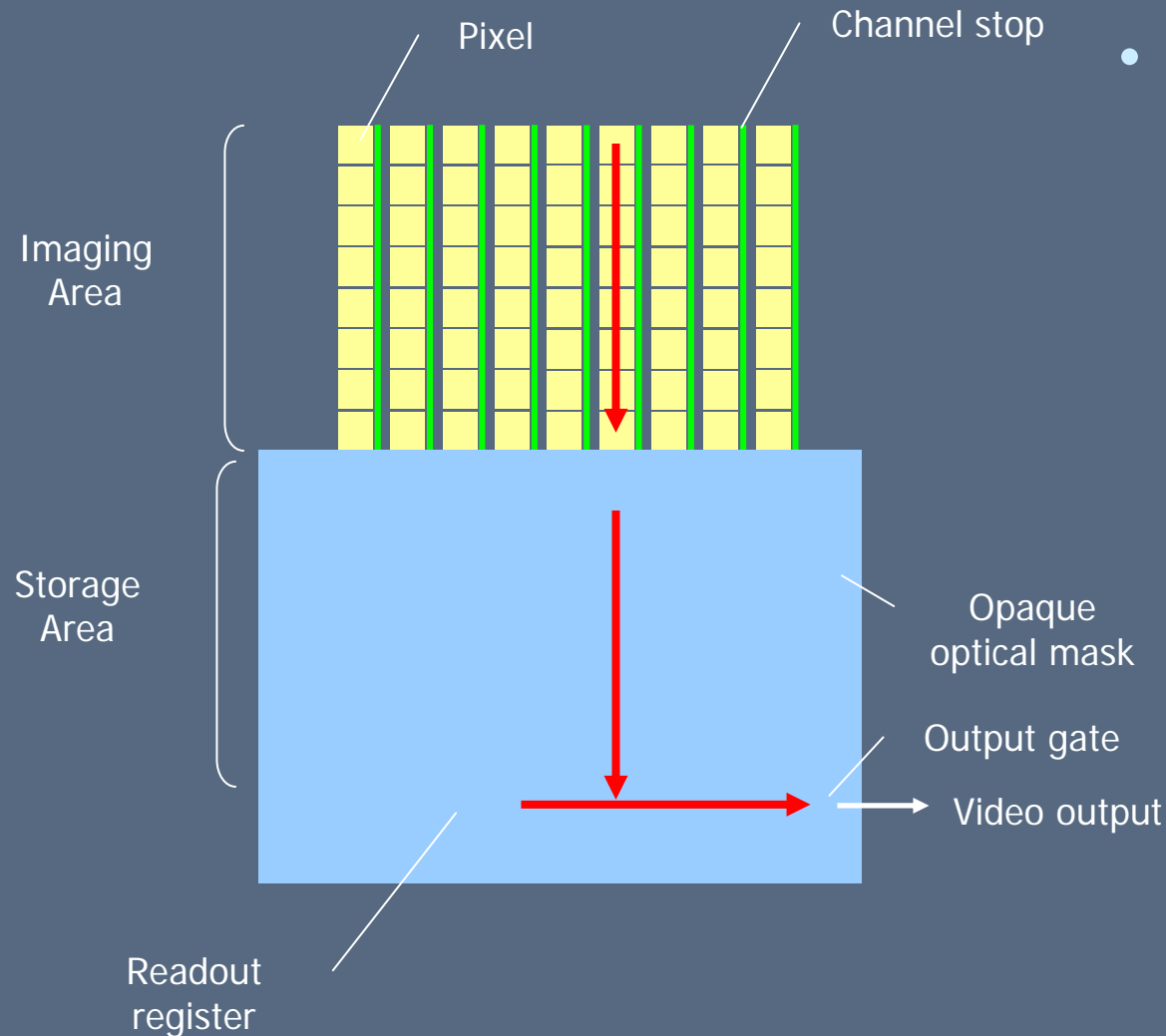
- Charge Coupled Device
 - Charge transfer through the device structure
- Single charge to voltage convertor at output
- Pixels addressed in predetermined sequence

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Types of CCD sensor

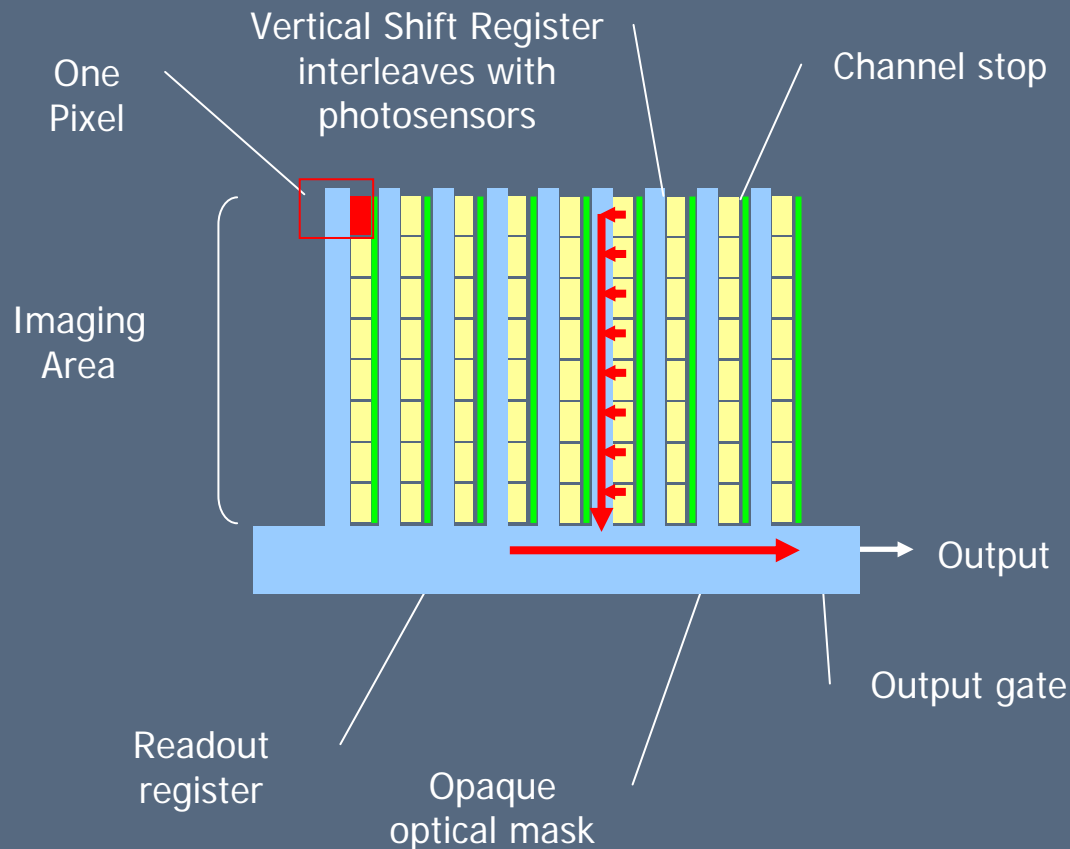
- FT (Frame Transfer)
- IT (Interline Transfer)
- FIT (Frame Interline Transfer)

Frame Transfer (FT)



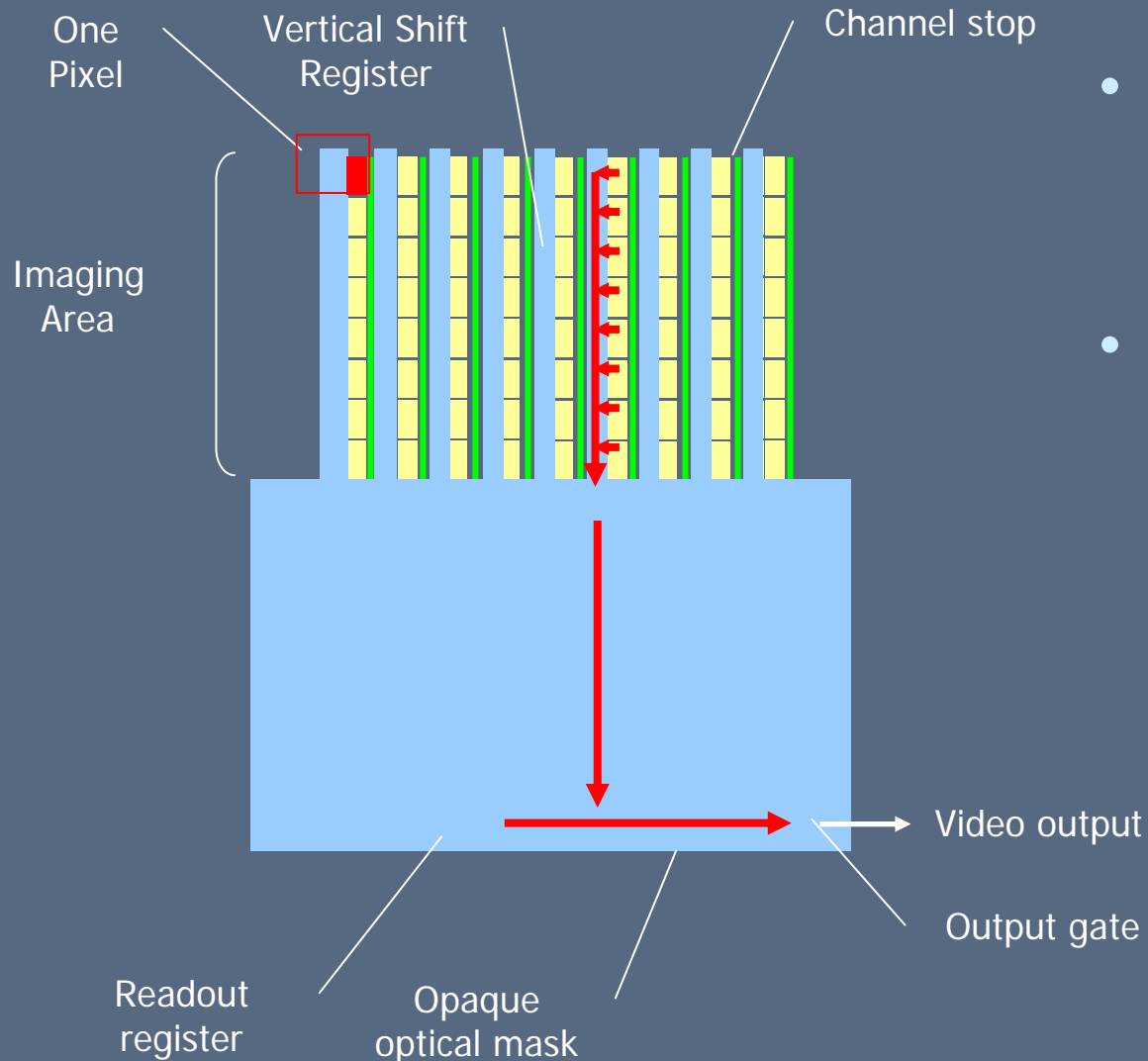
- Disadvantage:
 - requires optomechanical shutter
 - large physical size
 - pixels have to act as shift register
 - Rapid transfer to storage area is required

Interline Transfer (IT)



- Advantages
 - smaller physical size
 - Lower manufacturing cost
 - dedicated shift register
- Disadvantage:
 - smaller photosensitive area
 - possibility for light and/or charge to leak sideways into shift register to cause vertical smear

Frame Interline Transfer (FIT)



- Advantages
 - Separate storage area, immune to highlight effects
- Disadvantage:
 - large physical size
 - Complex structure

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CCD development

- In *concept*, CCD is unchanged since the mid 1980s
- In practice, there have been numerous refinements in the technology, and manufacturing process, leading to major user benefits

Factors to be considered

- Noise
- Sensitivity
- Dynamic range
- Highlight artefacts
- Resolution
- Aliasing
- Dark current
- Lag
- Shading/uniformity
 - Black and white
- Spectral Response
- Colour fidelity
- Flare
- Readout speed
- Power consumption
 - Smaller technology
 - Reduced supply voltage
- “Dead” pixels

Noise in CCD Sensors

- Many factors influence noise
 - Thermal noise, reset noise, $1/f$ noise
 - Optical shot noise
 - Fixed pattern noise
 - Caused by non uniformity of sensitivity and dark current
- Design improvements
 - Hole Accumulation Layer
 - Heavily doped layer at the surface of the sensor, used to minimise noise caused by impurities at the surface
 - Also eliminates lag due to poor readout efficiency
 - Correlated Double Sampling (CDS) readout amplifiers
 - Floating Diffusion Amplifier (FDA)

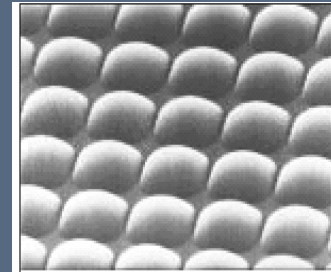
Dark Current

- *Dark current* is signal output from the sensor when no light reaches it
- Early sensors suffered badly from this effect
- Strongly temperature dependent
- Leads to shading and other effects
- Can be compensated by sensing output from extra (optically shielded) pixels.

- HAD sensor dramatically reduced this phenomenon.

Sensitivity of CCD Sensors

- Increased pixel counts leads to smaller pixels, and hence lower sensitivity
- Countered by:
 - better optical conversion efficiency
 - Micro Lenses
 - Individual lenses located above each pixel
- Note that different applications have differing sensitivity requirements



Highlight handling of CCD Sensors

- Vertical smear
- Highlight blooming
- Highlight lag
 - Have all been limitations of CCD devices
 - Smaller pixel sizes for HD can lead to reduced overload margin
 - FT sensors can also suffer from highlight artefacts
- Improvements in internal sensor structure has eliminated most causes of highlight problems
 - FIT technology has become redundant

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Sony Power HAD EX CCD

Technology Improvements

1985
HAD Sensor

- Low Dark Current
- E-Shutter

1990
On-Chip-Micro lens

- On-Chip-Lens Technology
→ High Sensitivity
Low Smear

1998
Power HAD CCD

- Re-construction (Gapless)
→ High Sensitivity

1999
New Construction CCD

- Internal Lens
→ High Sensitivity
- Thinner Insulation Film
→ Low Smear

2001
Power HAD EX CCD

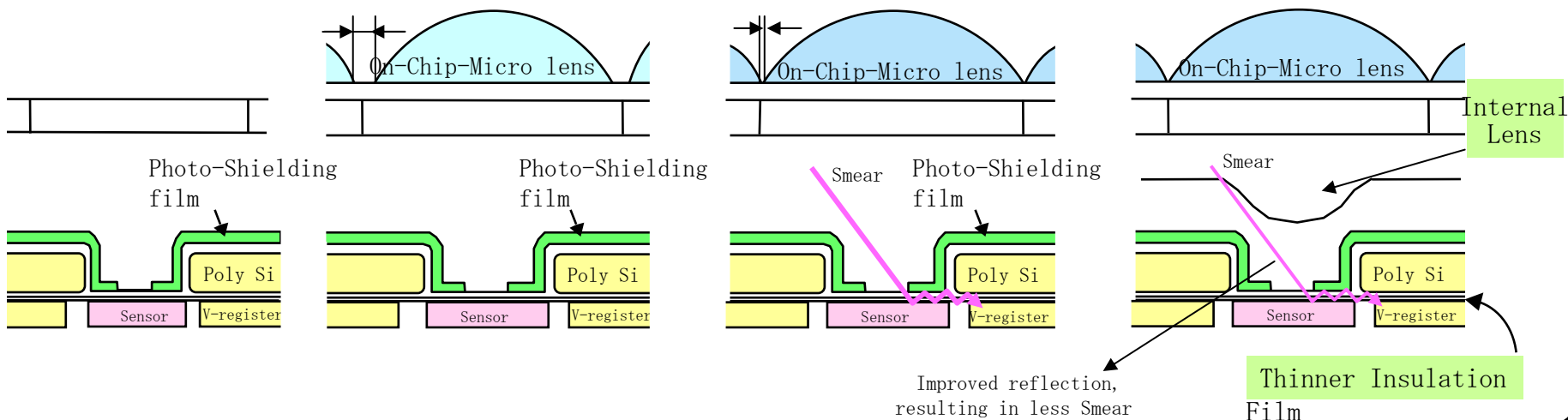
- Further Improvement
→ High Sensitivity
Low Smear

■ HAD Sensor

■ Hyper HAD

■ Power HAD CCD

■ Power HAD EX



Power consumption

- Improvements in semiconductor technology have allowed the use of ever smaller cell geometry
- Smaller geometry can use lower operating voltage, hence lower power consumption
- Lower power leads to additional benefit with lower noise level
 - But increased pixel numbers
 - = higher clock frequencies
 - = increased power!

Resolution and aliasing

- CCD resolution has risen to the point where in most circumstances it is the lens rather than the sensor which determines overall performance
- To minimise aliasing, good optical low pass filtering is required
 - Typically 3 dimensional LPF
- OLPF structure related to pixel size
 - Not possible with sensors which use variable pixel geometry

Shading and Uniformity

- Early CCD sensors had very poor uniformity, leading to noticeable picture degradation at low video levels
 - “dirty window” effect
- Largely eliminated on modern CCDs
- Potentially a bigger problem on CMOS devices, due to individual pixel amplifiers.
- Can be compensated using stored noise cancelling pattern, but introduces additional processing delay.

Spectral Response and Colour fidelity

- Early CCD sensors had poor blue sensitivity
 - early sensors used rear illumination of the sensor, which gave very low blue sensitivity
- Early CCD sensors had heavy infra-red filtering
 - Partially to reduce vertical smear due to deep electron generation
 - Partially to match plumbicon tube characteristics
- Modern devices have very wide spectral response

Quality Control

- Any manufacturing process is subject to a certain level of failures
- What is an acceptable level?
 - 1%?
 - 0.1%
 - 0.000045%
 - That would represent one pixel failure on an HD CCD sensor!
 - In Sony broadcast CCD sensors, even this level is not acceptable

Pixel Errors

- Pixels can have other failure modes, which result in a white spot (at black level) or dark spot (at white level)
- Not unique to any one type of sensor
- Pixel is still fully functional
 - Sony terminology is Residual Point Noise (RPN)
- Can be managed by compensation and concealment techniques
- These can be fully automatic and require no user intervention
- Undetectable in operation
- Provides effective field “repair”

HD CCD Technology today

- CCD devices have a long and successful history
- Well proven, mature technology
- Main performance limitations have been identified and eliminated or minimised
- Provide very satisfactory, reliable and stable operation

HD CCD Technology today

- Low noise
 - Fundamental technology improvements
- High sensitivity
 - Not quite at SD camera levels, but close
- Wide dynamic range/highlight handling
 - As good, or better than SD
- High clock rates, at reasonable power level
 - Frame rates up to 1080p/50
- Aliasing
 - Well controlled
- Shading
 - Negligible

CCD - CMOS Comparison

| | CCD | CMOS |
|--------------------------|---|-----------------------------------|
| Sensitivity | Excellent Efficiency of O-E conversion | Good Efficiency of AMP gain |
| S/N | Excellent FD AMP | Poor Performance of Transistor |
| Dark Current | Excellent Exclusive Process | Good CMOS LSI Process |
| Smear | Good Fundamental Phenomenon | No Smear Can be ignored |
| D-Range | Good | Good Depending on pixel no. |
| Power Consumption | Good | Excellent |

CMOS Benefits

- High speed
- Random access (scan invert, variable readout size)
- No smear
- Low power
- Potential for integration with processing

The future

- CMOS technology now starting to reach maturity
- Already in use for HD
 - Consumer
 - High-end
- Has benefits if higher resolution and/or higher frame rates are required
- Probably inevitable that it will spread to other applications
 - But the industry has more than 20 years experience with CCD technology, that will not be easily replaced

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HD in the real world

- Over 2000 units of Sony HD studio and OB cameras are in use world wide

HDCAM

- Over 5000 units of Sony HDCAM camcorders are in use worldwide
- And now,

HDV

- Since the beginning of 2005, more than 15000 units (consumer and professional) have been sold.
- HD for Everyone

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